

Search Notes

Application/Control No.

10/817,279

Examiner

Phallaka Kik

Applicant(s)/Patent under
Reexamination

MEANEY ET AL.

Art Unit

2825

SEARCHED

Class	Subclass	Date	Examiner
716	2,7,18	11/29/2006	PK
370	203	11/29/2006	PK
710	33,36	11/29/2006	PK
709	238	11/29/2006	PK
Above	updated	5/18/2007	PK

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
716	2,7,18	5/18/2007	PK
370	203	5/18/2007	PK
710	33,36	5/18/2007	PK
709/238 --USPGPUB (see attached)		5/18/2007	PK

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
BRS (EAST) Updated and new search --USPAT, USPGPUB Class/sub searched: 716/1-18 (see attached)	11/29/2006	PK
--USPAT, USPGPUB (Continue) Cks/sub searched: 370/203-211; 710/33-42; 709/238-240, 201-203, 213-216 (see attached)	11/29/2006	PK
Above updated (see attached)	5/18/2007	PK
New search --EPO, JPO, IBM TDB, Derwent (see attached)	11/29/2006	PK
IEE/IEEE Xplore New Search (see attached)	11/29/2006	PK